

MOSFET - Power, Single N-Channel, TOLL 60 V, 0.9 mΩ, 422 A



ON Semiconductor®

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NVBLS001N06C

Features

- Low $R_{DS(on)}$ to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	V_{DSS}	60	V	
Gate-to-Source Voltage	V_{GS}	± 20	V	
Continuous Drain Current $R_{\theta JC}$ (Note 2)	Steady State	$T_C = 25^\circ\text{C}$	I_D 422	A
		$T_C = 100^\circ\text{C}$	298	
Power Dissipation $R_{\theta JC}$ (Note 2)	Steady State	$T_C = 25^\circ\text{C}$	P_D 284	W
		$T_C = 100^\circ\text{C}$	142	
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2)	Steady State	$T_A = 25^\circ\text{C}$	I_D 51	A
		$T_A = 100^\circ\text{C}$	36	
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)	Steady State	$T_A = 25^\circ\text{C}$	P_D 4.2	W
		$T_A = 100^\circ\text{C}$	2.1	
Pulsed Drain Current	$T_A = 25^\circ\text{C}, t_p = 10 \mu\text{s}$	I_{DM} 900	A	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to +175	$^\circ\text{C}$	
Source Current (Body Diode)	I_S	236	A	
Single Pulse Drain-to-Source Avalanche Energy ($I_{L(pk)} = 39 \text{ A}$)	E_{AS}	760	mJ	
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)	T_L	260	$^\circ\text{C}$	

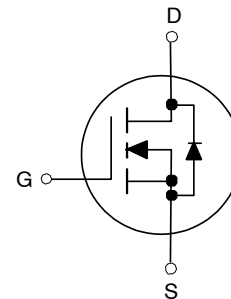
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	0.53	$^\circ\text{C}/\text{W}$
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	36	

1. Surface-mounted on FR4 board using a 1 in² pad size, 2 oz. Cu pad.
2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

$V_{(BR)DSS}$	$R_{DS(ON) MAX}$	$I_D MAX$
60 V	0.9 mΩ @ 10 V	422 A



H-PSOF8L
CASE 100CU

ORDERING INFORMATION

Device	Package	Shipping†
NVBLS001N06C	H-PSOF8L (Pb-Free)	2000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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Table 1. ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{V}$	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	$I_D = 562 \mu\text{A}, \text{ref to } 25^\circ\text{C}$		26		mV/ $^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 60 \text{V}, V_{GS} = 0 \text{V}$	$T_J = 25^\circ\text{C}$		10	μA
			$T_J = 125^\circ\text{C}$		100	μA
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0 \text{V}, V_{GS} = 20 \text{V}$			100	nA

ON CHARACTERISTICS (Note 3)

Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS} = V_{DS}, I_D = 562 \mu\text{A}$	2.0	2.8	4.0	V
Negative Threshold Temperature Coefficient	$V_{GS(th)}/T_J$	$I_D = 562 \mu\text{A}, \text{ref to } 25^\circ\text{C}$		9.9		mV/ $^\circ\text{C}$
Drain-to-Source On Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{V}, I_D = 80 \text{A}$		0.75	0.9	m Ω
Forward Transconductance	g_{FS}	$V_{DS} = 5 \text{V}, I_D = 80 \text{A}$		290		S

CHARGES & CAPACTIANCES

Input Capacitance	C_{iss}	$V_{GS} = 0 \text{V}, V_{DS} = 30 \text{V}, f = 10 \text{kHz}$		11575		pF
Output Capacitance	C_{oss}			5973		pF
Reverse Transfer Capacitance	C_{riss}			76		pF
Total Gate Charge	$Q_{G(tot)}$	$V_{GS} = 10 \text{V}, V_{DS} = 30 \text{V}, I_D = 80 \text{A}$		143		nC
Threshold Gate Charge	$Q_{G(th)}$			31		nC
Gate-to-Source Charge	Q_{gs}			54		nC
Gate-to-Drain Charge	Q_{gd}			13		nC

SWITCHING CHARACTERISTICS, $V_{GS} = 10 \text{V}$ (Note 3)

Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 10 \text{V}, V_{DS} = 30 \text{V}, I_D = 80 \text{A}, R_G = 6 \Omega$		34		ns
Rise Time	t_r			53		ns
Turn-Off Delay Time	$t_{d(off)}$			119		ns
Fall Time	t_f			91		ns

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage	V_{SD}	$I_S = 80 \text{A}, V_{GS} = 0 \text{V}$	$T_J = 25^\circ\text{C}$		0.79	1.2	V
		$I_S = 80 \text{A}, V_{GS} = 0 \text{V}$	$T_J = 125^\circ\text{C}$		0.66		V
Reverse Recovery Time	t_{rr}	$V_{GS} = 0 \text{V}, di_S/dt = 100 \text{A}/\mu\text{s}, I_S = 56 \text{A}$		120		ns	
Charge Time	t_a			60		ns	
Discharge Time	t_b			60		ns	
Reverse Recovery Charge	Q_{rr}			322		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures

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TYPICAL CHARACTERISTICS

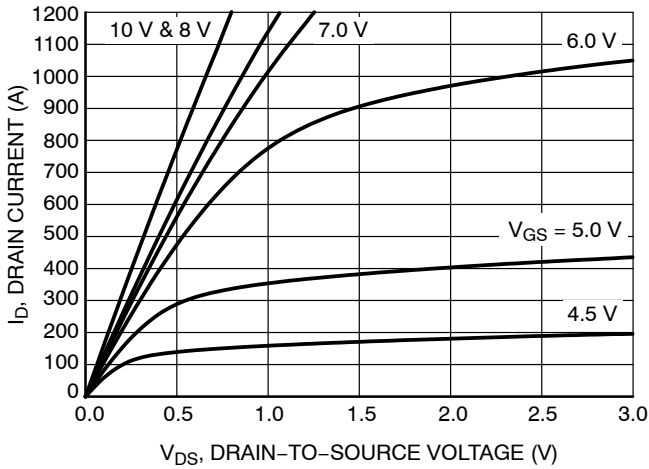


Figure 1. On-Region Characteristics

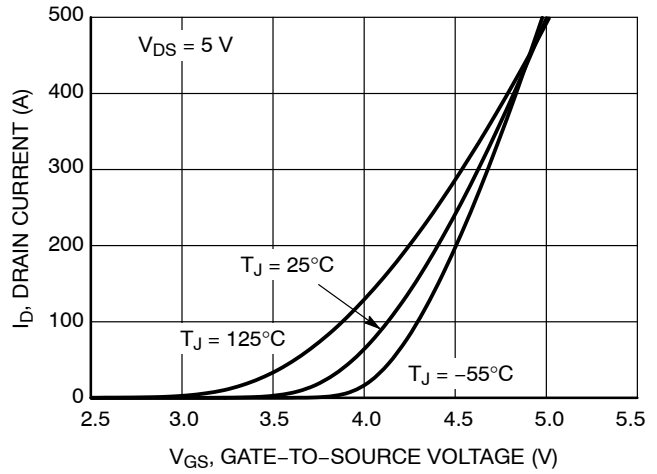


Figure 2. Transfer Characteristics

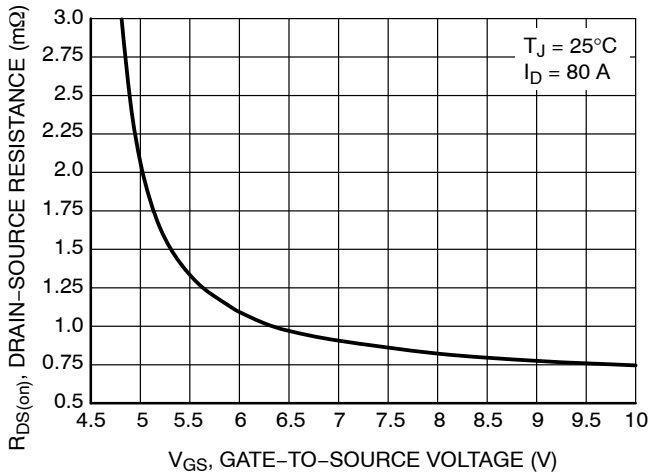


Figure 3. On-Resistance vs. V_{GS}

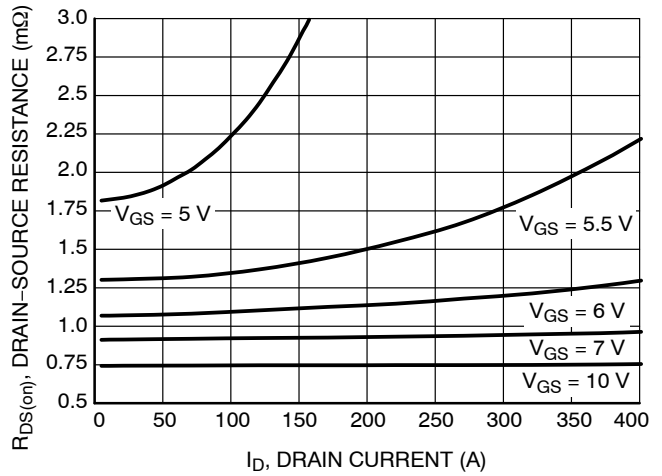


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

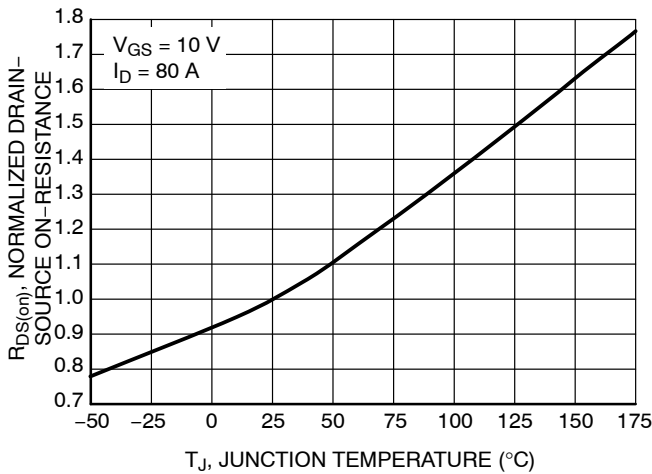


Figure 5. On-Resistance Variation with Temperature

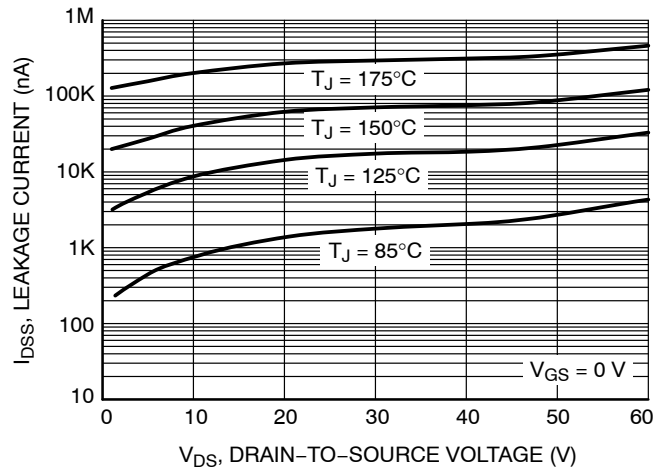


Figure 6. Drain-to-Source Leakage Current vs. Voltage

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TYPICAL CHARACTERISTICS

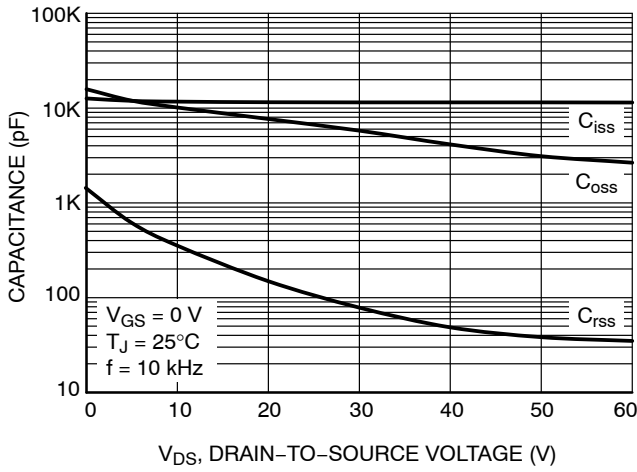


Figure 7. Capacitance Variation

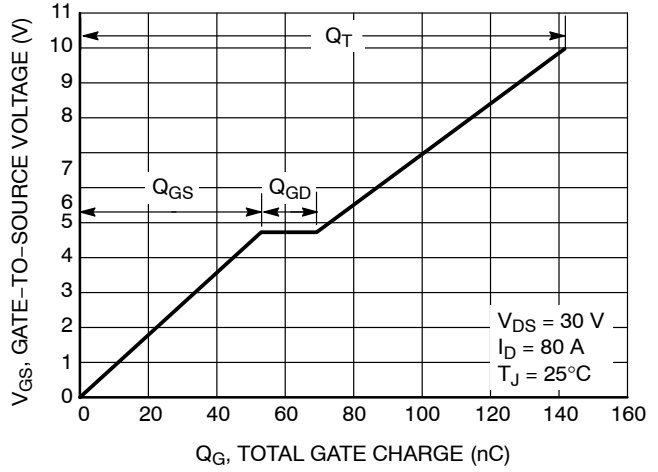


Figure 8. Gate-to-Source Voltage vs. Total Gate Charge

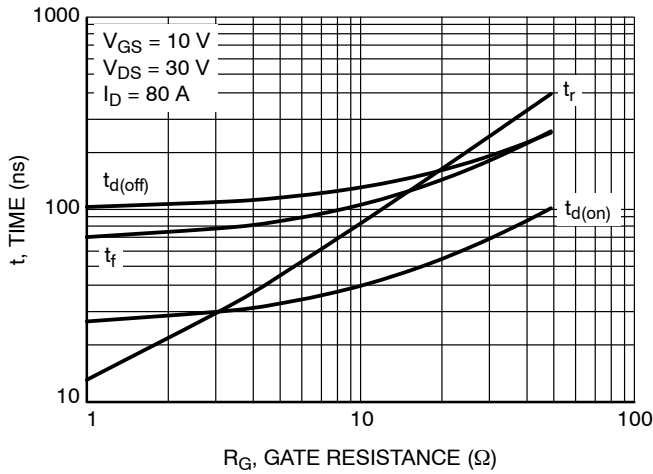


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

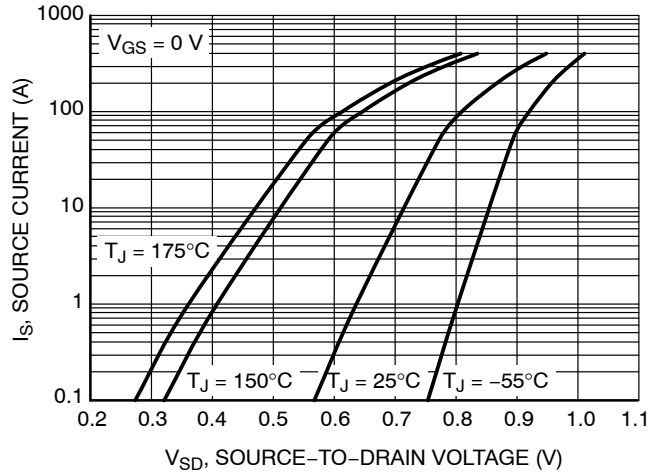


Figure 10. Diode Forward Voltage vs. Current

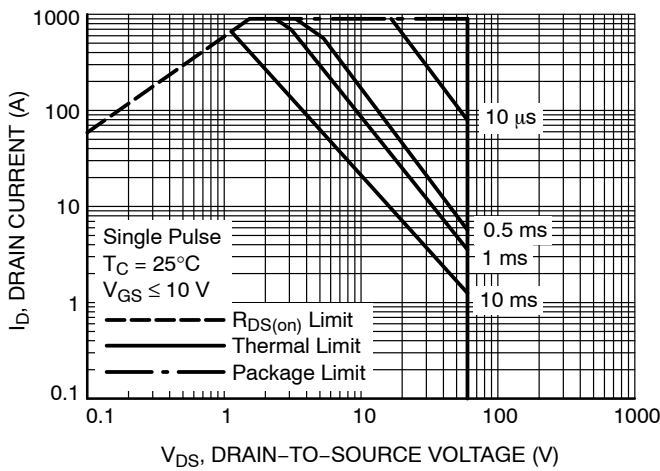


Figure 11. Maximum Rated Forward Biased Safe Operating Area

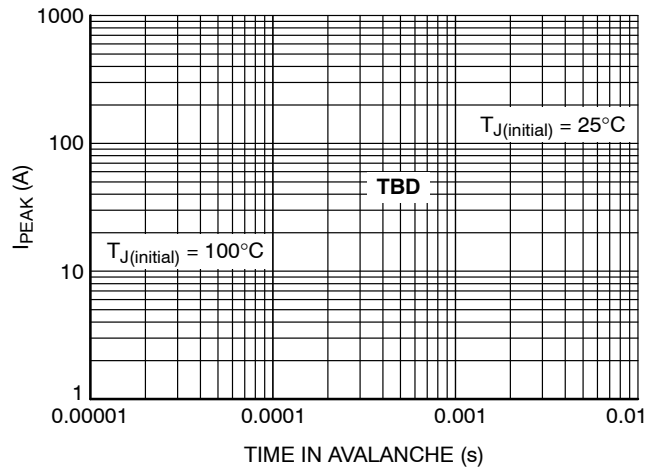


Figure 12. Peak Power

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TYPICAL CHARACTERISTICS

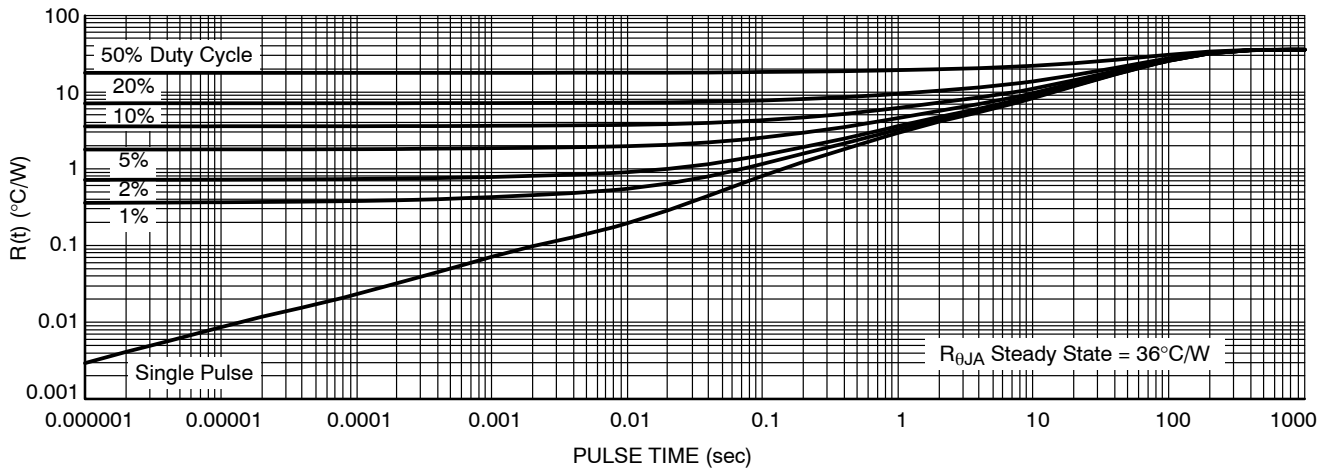
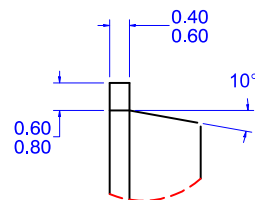
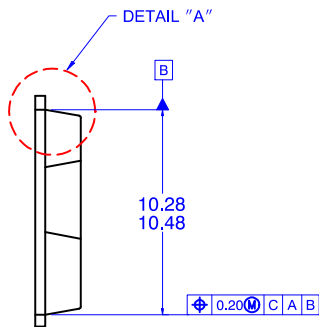
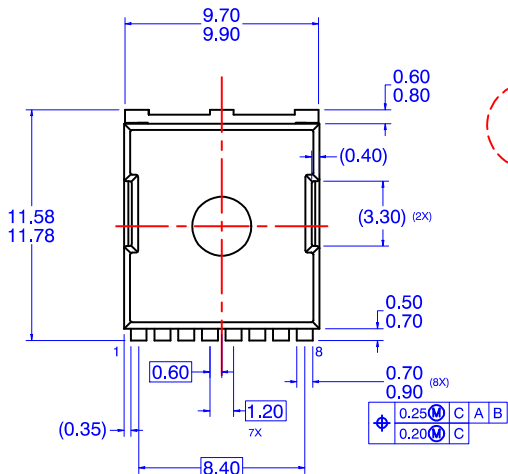


Figure 13. Thermal Characteristics (Junction-to-Ambient)

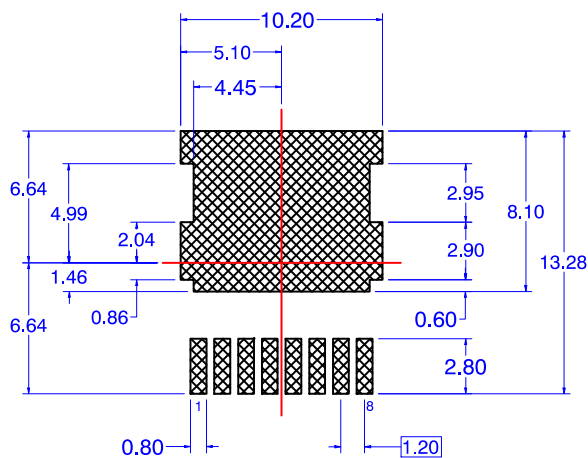
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PACKAGE DIMENSIONS

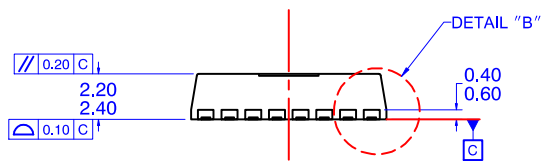
H-PSOF8L 11.68x9.80
CASE 100CU
ISSUE O



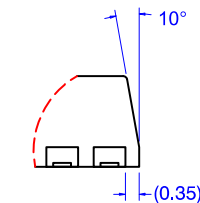
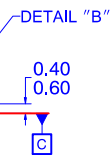
DETAIL "A"



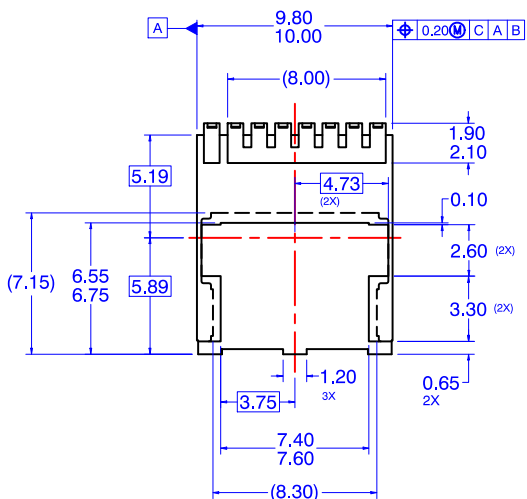
LAND PATTERN RECOMMENDATION



SIDE VIEW



DETAIL "B"



BOTTOM VIEW

NOTES: UNLESS OTHERWISE SPECIFIED

- A) PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE A, DATED NOVEMBER 2009.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

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